

<b>Notice of References Cited</b>	Application/Control No. 10/602,600		Applicant(s)/Patent Under Reexamination IKEUCHI ET AL.	
	Examiner Roberta Prendergast		Art Unit 2628	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,008,813	12-1999	Lauer et al.	345/424
*	B	US-6,009,188	12-1999	Cohen et al.	382/154
*	C	US-6,023,523	02-2000	Cohen et al.	382/154
*	D	US-6,028,955	02-2000	Cohen et al.	382/154
*	E	US-6,215,496	04-2001	Szeliski et al.	345/419
*	F	US-6,219,061	04-2001	Lauer et al.	345/424
*	G	US-6,243,098	06-2001	Lauer et al.	345/424
*	H	US-6,262,740	07-2001	Lauer et al.	345/424
*	I	US-6,342,886	01-2002	Pfister et al.	345/424
*	J	US-6,373,483	04-2002	Becker et al.	345/419
*	K	US-6,396,496	05-2002	Pfister et al.	345/427
*	L	US-6,424,352	07-2002	Sharma et al.	345/602
*	M	US-6,448,968	09-2002	Pfister et al.	345/423

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Carceroni, R.L.; Katalakos, K.N.; "Multi-view scene capture by surfel sampling: from video streams to non-rigid 3D motion, shape and reflectance", Proceedings 8th IEEE International Conference on Computer Vision, ICCV 2001, Volume 2, July 2001, pages 60-67.			
	V	Mueller, K.; Shareef, N.; Jian Huang; Crawfis, R.; "High-quality splatting on rectilinear grids with efficient culling of occluded voxels", IEEE Transactions on Visualization and Computer Graphics, Volume 5, Issue 2, April-June 1999, pages 116-134.			
	W	Mueller, K. and Crawfis, R.; "Eliminating popping artifacts in sheet buffer-based splatting", Proceedings of the Conference on Visualization '98, October 18 - 23, 1998, IEEE Visualization, IEEE Computer Society Press, pages 239-245.			
	X	Laur, D. and Hanrahan, P.; "Hierarchical splatting: a progressive refinement algorithm for volume rendering", Proceedings of the 18th Annual Conference on Computer Graphics and Interactive Techniques, SIGGRAPH '91, ACM Press, NY, NY, pages 285-288, SIGGRAPH 1991.			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 10/602,600	Applicant(s)/Patent Under Reexamination IKEUCHI ET AL.	
		Examiner Roberta Prendergast	Art Unit 2628	Page 2 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,466,207	10-2002	Gortler et al.	345/427
*	B	US-6,480,190	11-2002	Pfister et al.	345/419
*	C	US-6,498,607	12-2002	Pfister et al.	345/423
*	D	US-6,509,902	01-2003	Pfister et al.	345/582
*	E	US-6,674,430	01-2004	Kaufman et al.	345/419
*	F	US-2002/0061131	05-2002	Sawhney et al.	382/154
*	G	US-2003/0001838	01-2003	Han et al.	345/419
*	H	US-2003/0011596	01-2003	Zhang et al.	345/426
*	I	US-2003/0052878	03-2003	Han et al.	345/420
*	J	US-2003/0214502	11-2003	Park et al.	345/420
*	K	US-2004/0095357	05-2004	Oh et al.	345/589
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Westover, L.; "Footprint evaluation for volume rendering", Proceedings of the 17th Annual Conference on Computer Graphics and Interactive Techniques, SIGGRAPH 1990, ACM Press, NY, NY, pages 367-376.			
	V	Zwicker, M.; Pfister, H.; van Baar, J.; Gross, M.; "EWA splatting", IEEE Transactions on Visualization and Computer Graphics, Volume 8, Issue 3, July-Sept. 2002, pages 223-238.			
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.